Unit: mm

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π-MOSIV)

2SK3565

Switching Regulator Applications

- Low drain-source ON resistance: RDS (ON) = 2.0Ω (typ.)
- High forward transfer admittance: $|Y_{fs}| = 4.5 \mathrm{S}$ (typ.)
- Low leakage current: IDSS = 100 μ A (VDS = 720 V)
- Enhancement mode: $V_{th} = 2.0 \sim 4.0 \text{ V (V}_{DS} = 10 \text{ V, I}_{D} = 1 \text{ mA})$

Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	900	V	
Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)		V _{DGR}	900	V	
Gate-source voltage		V _{GSS}	±30	٧	
Drain current	DC (Note 1)	ID	5	А	
	Pulse (t = 1 ms) (Note 1)	I _{DP}	15		
Drain power dissipati	on (Tc = 25°C)	P _D	45	W	
Single pulse avalanche energy (Note 2)		E _{AS}	595	mJ	
Avalanche current		I _{AR}	5	Α	
Repetitive avalanche energy (Note 3)		E _{AR}	4.5	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55~150	°C	

Thermal Characteristics

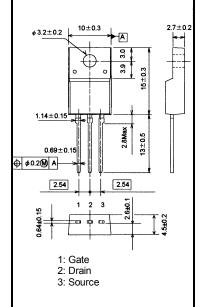
Characteristics	Symbol	Max	Unit	
Thermal resistance, channel to case	R _{th (ch-c)}	2.78	°C/W	
Thermal resistance, channel to ambient	R _{th (ch-a)}	62.5	°C/W	

Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2: $V_{DD} = 90~V,~T_{ch} = 25^{\circ}C(Initial),~L = 43.6~mH,~I_{AR} = 5.0~A,~R_G = 25~\Omega$

Note 3: Repetitive rating: pulse width limited by maximum channel temperature

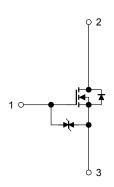
This transistor is an electrostatic-sensitive device. Please handle with caution.



Weight: 1.7 g (typ.)

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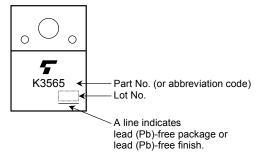
Electrical Characteristics (Ta = 25°C)

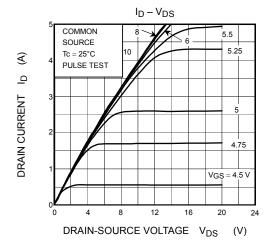
Chara	acteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cur	rent	I _{GSS}	$V_{GS} = \pm 25 \text{ V}, V_{DS} = 0 \text{ V}$		_	±10	μА
Gate-source brea	kdown voltage	V (BR) GSS	$I_G=\pm 10~\mu A,~V_{DS}=0~V$	±30	_	_	V
Drain cut-off curre	ent	I _{DSS}	V _{DS} = 720 V, V _{GS} = 0 V		_	100	μА
Drain-source brea	akdown voltage	V (BR) DSS	$I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	900	_	_	V
Gate threshold vo	oltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	2.0	_	4.0	V
Drain-source ON	resistance	R _{DS (ON)}	V _{GS} = 10 V, I _D = 3 A		2.0	2.5	Ω
Forward transfer	admittance	Yfs	V _{DS} = 20 V, I _D = 3 A	2.0	4.5	_	S
Input capacitance	÷	C _{iss}		_	1150	_	
Reverse transfer capacitance		C _{rss}	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		20	_	pF
Output capacitance		C _{oss}			100		
Switching time	Rise time	t _r	V_{GS} $V_{DD} \simeq 200 \text{ V}$ $V_{DD} \simeq 200 \text{ V}$	_	30	_	
	Turn-on time	t _{on}		_	70		
	Fall time	t _f		_	60		ns
	Turn-off time	t _{off}	Duty \leq 1%, $t_W = 10 \mu s$	_	170		
Total gate charge		Qg		_	28	_	
Gate-source charge		Q _{gs}	$V_{DD} \simeq 400 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 5 \text{ A}$	_	17	_	nC
Gate-drain charge		Q _{gd}			11	_	

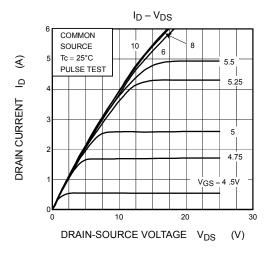
Source-Drain Ratings and Characteristics (Ta = 25°C)

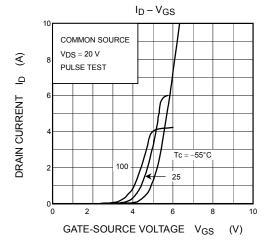
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	_	_	_	5	Α
Pulse drain reverse current (Note 1)	I _{DRP}	_	_	_	15	Α
Forward voltage (diode)	V _{DSF}	$I_{DR} = 5 \text{ A}, V_{GS} = 0 \text{ V}$	_	_	-1.7	V
Reverse recovery time	t _{rr}	$I_{DR} = 5 \text{ A}, V_{GS} = 0 \text{ V},$	_	900	_	ns
Reverse recovery charge	Q _{rr}	dI _{DR} /dt = 100 A/μs	_	5.4	_	μС

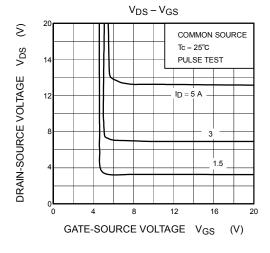
Marking

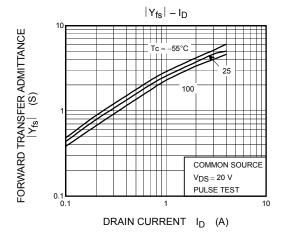


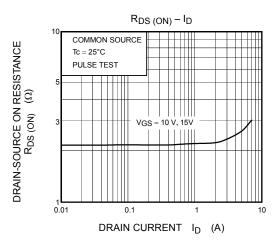


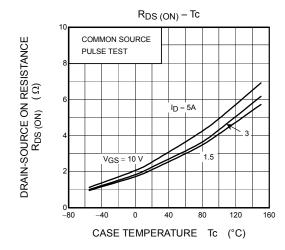


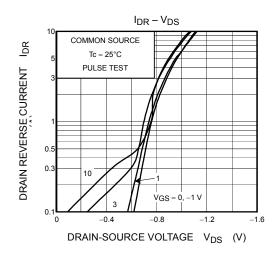


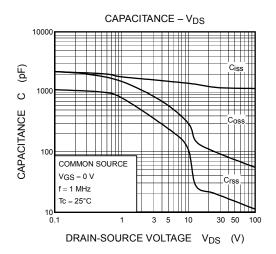


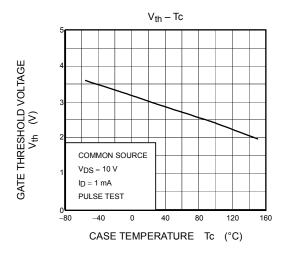


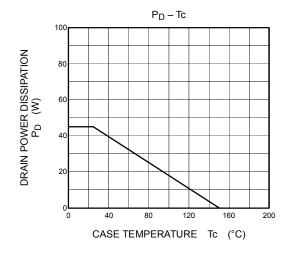


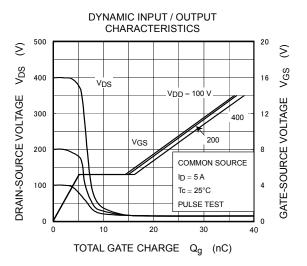


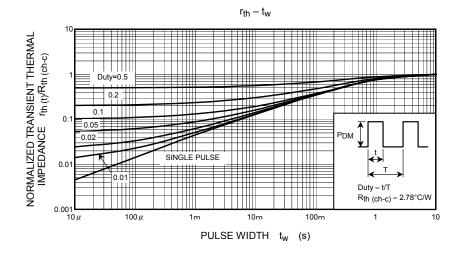


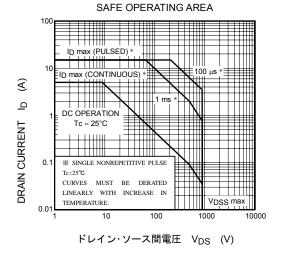


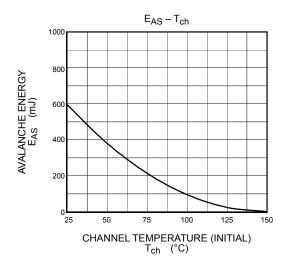


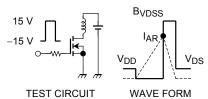












$$R_G = 25 \Omega$$

$$V_{DD} = 90 \text{ V}, L = 43.6 \text{mH}$$

$$E_{AS} = \frac{1}{2} \cdot L \cdot I^2 \cdot \left(\frac{B_{VDSS}}{B_{VDSS} - V_{DD}} \right)$$

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